





LM74722-Q1

SLVSFR9B - SEPTEMBER 2021 - REVISED AUGUST 2022

# LM74722-Q1 Automotive Low IQ Ideal Diode Controller with 200-kHz Active Rectification and Load Dump Protection

#### 1 Features

- AEC-Q100 qualified with the following results
  - Device temperature grade 1: -40°C to +125°C ambient operating temperature range
  - Device HBM ESD classification level 2
  - Device CDM ESD classification level C4B
- 3-V to 65-V input range
- Reverse input protection down to -65 V
- Low quiescent current 35 µA (max) in operation
- Low 3.3- $\mu$ A (max) shutdown current (EN = Low)
- Ideal diode operation with 13-mV A to C forward voltage drop regulation
- Drives external back-to-back N-Channel MOSFETs
- Integrated 30-mA boost regulator
- Active rectification up to 200 kHz
- Fast response to reverse current blocking: 0.5 µs
- Fast forward GATE turn ON delay: 0.72 µs
- Adjustable overvoltage protection
- Meets automotive ISO7637 transient requirements with a suitable TVS diode
- Available in space saving 12-pin WSON package

## 2 Applications

- · Automotive battery protection
  - ADAS domain controller
  - Premium audio amplifier
  - Head unit

#### **VBATT** VOUT 12 V CAP PD GATE D1 SMBJ36C VSNS SW LM74722-Q1 BATT MON ΕN ON OFF GND Low IQ Ideal Diode

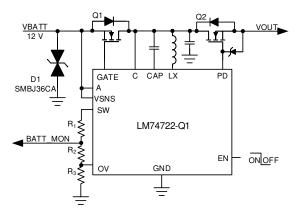
## 3 Description

The LM74722-Q1 ideal diode controller drives and controls external back-to-back N-Channel MOSFETs to emulate an ideal diode rectifier with power path ON and OFF control and overvoltage protection. The wide input supply of 3 V to 65 V allows protection and control of 12-V and 24-V automotive battery powered ECUs. The device can withstand and protect the loads from negative supply voltages down to -65 V. An integrated ideal diode controller (GATE) drives the first MOSFET to replace a Schottky diode for reverse input protection and output voltage holdup. A strong boost regulator with fast turn-ON and OFF comparators ensures robust and efficient MOSFET switching performance during automotive testing, such as ISO16750 or LV124, where an ECU is subjected to input short interruptions and AC superimpose input signals up to 200-kHz frequency. Low quiescent current 35 µA (maximum) in operation enables always ON system designs. With a second MOSFET in the power path, the device allows load disconnect control using EN pin. Quiescent current reduces to 3.3 µA (maximum) with EN low. The device features an adjustable overvoltage cutoff or overvoltage clamp protection using OV pin.

### **Device Information**

| PART NUMBER | PACKAGE <sup>(1)</sup> | BODY SIZE (NOM)   |
|-------------|------------------------|-------------------|
| LM74722-Q1  | WSON (12)              | 3.00 mm × 3.00 mm |

For all available packages, see the orderable addendum at the end of the data sheet.



Low IQ Ideal Diode with Switched Output



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# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Ch | Changes from Revision A (February 2022) to Revision B (August 2022)                                 |      |  |
|----|---|------|--|
| •  | Changed status from "Advance Information" to "Production Data"                                      |      |  |
|    |   |      |  |
| Ch | anges from Revision * (September 2021) to Revision A (February 2022)                                | Page |  |
|    | langes from Revision * (September 2021) to Revision A (February 2022)  Updated the data sheet title |      |  |



# **5 Pin Configuration and Functions**

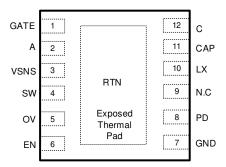


Figure 5-1. WSON 12-Pin DRR Transparent Top View

**Table 5-1. Pin Functions** 

| P    | PIN           |      |  |  |  |
|------|---------------|------|--|--|--|
|      | LM74722-Q1    | TYPE | DESCRIPTION  |  |  |
| NAME | DRR-12 (WSON) |      |  |  |  |
| GATE | 1             | 0    | Diode controller gate drive output. Connect to the GATE of the external MOSFET.  |  |  |
| А    | 2             | I    | Anode of the ideal diode. Connect to the source of the external MOSFET.  |  |  |
| VSNS | 3             | I    | Voltage sensing input  |  |  |
| sw   | 4             | ı    | Voltage sensing disconnect switch terminal. VSNS and SW connect internally through a switch. Use SW as the top connection of the battery sensing or OV resistor ladder network. When EN is pulled low, the switch is OFF disconnecting the resistor ladder from the battery line, thereby cutting off the leakage current. If the internal disconnect switch between VSNS and SW is not used, then short them together and connect to C pin. |  |  |
| OV   | 5             | I    | Adjustable overvoltage threshold input. Connect a resistor ladder across SW to OV terminal. When the voltage at OV exceeds the over voltage cut-off threshold, then the PD is pulled low turning OFF the HSFET. PD is driven high when the sense voltage goes below the OV falling threshold.  |  |  |
| EN   | 6             | I    | EN input. Connect to A or C pin for always ON operation. In this mode, the device consumes an IQ of 35 μA (maximum) that can be driven externally from a micro controller I/O. Pulling this pin low below 0.3 V enters the device in low Iq shutdown mode.   |  |  |
| GND  | 7             | G    | Connect to the system ground plane.  |  |  |
| PD   | 8             | 0    | Pull down connection for the external HSFET. Connect to the GATE of the external FET. Keep PD pin floating when not used.  |  |  |
| N.C  | 9             | I    | No connect   |  |  |
| LX   | 10            | I    | Switch node of the internal boost regulator. This node must be kept small on the PCB for good performance and low EMI. Connect the boost inductor between this pin and the DRAIN connection of the external FET.   |  |  |
| CAP  | 11            | 0    | Boost regulator output. This pin is used to provide a drive voltage to the gate driver of the ideal diode stage as well as drive supply for the HSFET. Connect a 1-µF capacitor between this pin and the DRAIN connection of the external FET.   |  |  |
| С    | 12            | I    | Cathode of the ideal diode and supply voltage pin. Connect to the DRAIN of the external MOSFET. The voltage sensed at this pin is used to control the external MOSFET GATE. This pin must be locally bypassed with at least 1 µF.  |  |  |
| RTN  | Thermal Pad   | _    | Leave exposed pad floating. Do not connect to GND plane.   |  |  |

## **6 Specifications**

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

|                                       |  | MIN              | MAX                | UNIT |
|---------------------------------------|--|------------------|--------------------|------|
| Input Pins                            | A to GND   | -65              | 70                 | V    |
| Input Pins                            | C to GND   | -0.3             | 70                 | V    |
| Input Pins                            | VSNS, SW, EN, OV to GND, V <sub>(A)</sub> > 0 V            | -0.3             | 70                 | V    |
| Input Pins                            | VSNS, SW, EN, OV to GND, $V_{(A)} \le 0 \text{ V}$         | V <sub>(A)</sub> | $(70 + V_{(A)})$   | V    |
| Input Pins                            | RTN to GND   | -65              | 0.3                | V    |
| Input Pins                            | I <sub>VSNS</sub> , I <sub>SW</sub>                        | -1               | 10                 | mA   |
| Input Pins                            | I <sub>EN</sub> , I <sub>OV</sub> , V <sub>(A)</sub> > 0 V | -1               |                    | mA   |
| Input Pins                            | $I_{EN}, I_{OV}, V_{(A)} \le 0 \text{ V}$                  | Internally       | Internally limited |      |
| Output Pins                           | CAP to C   | -0.3             | 15.9               | V    |
| Output Pins                           | CAP to A   | -0.3             | 85                 | V    |
| Output Pins                           | GATE to A  | -0.3             | 15                 | V    |
| Output Pins                           | LX, CAP, PD to GND   | -0.3             | 85                 | V    |
| Output to Input Pins                  | C to A   | <b>–</b> 5       | 85                 | V    |
| Operating junction temperation        | -40  | 150              | °C                 |      |
| Storage temperature, T <sub>stg</sub> |  | -40              | 150                | °C   |

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime

## 6.2 ESD Ratings

|                    |     |   |                                | VALUE | UNIT |
|--------------------|-----|---|--------------------------------|-------|------|
|                    |     | Human body model (HBM), per AEC Q100-002 <sup>(1)</sup> |                                | ±2000 |      |
| V <sub>(ESD)</sub> | , , | Charged device model (CDM),<br>per AEC Q100-011         | Corner pins (GATE, EN, GND, C) | ±750  | V    |
|                    |     | per ALO Q100-011  | Other pins                     | ±500  |      |

<sup>(1)</sup> AEC-Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specifications.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

|  |   | MIN | NOM | MAX | UNIT |
|--|---|-----|-----|-----|------|
|  | A to GND  | -60 |     | 65  |      |
| Input Pins                                       | C to GND  |     |     | 65  | V    |
|  | EN to GND   | -60 |     | 65  |      |
| External   | A   | 0.1 |     |     | μF   |
| capacitance                                      | VS, C, CAP to C                                     | 1   |     |     | μF   |
| External Inductor                                | LX  | 100 |     |     | μН   |
| External<br>MOSFET max<br>V <sub>GS</sub> rating | GATE to A   | 15  |     |     | V    |
| TJ   | Operating junction temperature range <sup>(2)</sup> | -40 |     | 150 | °C   |

Recommended Operating Conditions are conditions under which the device is intended to be functional. For specifications and test conditions, see *Electrical Characteristics*.

Product Folder Links: LM74722-Q1

<sup>(2)</sup> High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

(2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

### **6.4 Thermal Information**

|  |  | LM74722-Q1 |      |
|--|--|------------|------|
|  | THERMAL METRIC <sup>(1)</sup>                | DRR (WSON) | UNIT |
|  |  | 12 PINS    |      |
| $R_{\theta JA}$  | Junction-to-ambient thermal resistance       | 61.6       | °C/W |
| R <sub>θJC(top)</sub>  | Junction-to-case (top) thermal resistance    | 50         | °C/W |
| R <sub>0JB</sub>   | Junction-to-board thermal resistance         | 32.7       | °C/W |
| $\Psi_{JT}$  | Junction-to-top characterization parameter   | 1.4        | °C/W |
| Ψ <sub>JB</sub> Junction-to-board characterization parameter |  | 32.7       | °C/W |
| $R_{\theta JC}$  | Junction-to-case (botton) thermal resistance | 6.9        | °C/W |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

## 6.5 Electrical Characteristics

 $T_J$  = -40°C to +125°C; typical values at  $T_J$  = 25°C,  $V_{(A)}$  =  $V_{(C)}$  = 12 V,  $C_{(CAP)}$  = 1  $\mu$ F,  $V_{(EN)}$  = 2 V, over operating free-air temperature range (unless otherwise noted)

|   | PARAMETER  | TEST CONDITIONS   | MIN | TYP  | MAX  | UNIT |
|---|--|---|-----|------|------|------|
| V <sub>A</sub> SUPPLY VOI               | LTAGE  |   |     |      |      |      |
| V                                       | VA POR Rising threshold                                  |   | 3.1 | 3.4  | 3.85 |      |
| V <sub>(A POR)</sub>                    | VA POR Falling threshold                                 |   | 2.2 | 2.6  | 2.9  | V    |
| V <sub>(C)</sub>                        | Minimum voltage at C                                     |   |     |      | 3    |      |
| I <sub>(SHDN)</sub>                     | Shutdown Supply Current                                  | V <sub>(EN)</sub> = 0 V   |     | 1.5  | 3.3  |      |
| 1                                       | Total System Ovicesent Current                           | $V_{(EN)}$ = 2 V, Active Rectifier Controller In Regulation, -40°C $\leq$ T <sub>J</sub> $\leq$ +85°C     |     | 27   | 32   | μΑ   |
| $I_{(Q)}$                               | Total System Quiescent Current                           | $V_{(EN)}$ = 2 V, Active Rectifier Controller<br>In Regulation, -40°C $\leq$ T <sub>J</sub> $\leq$ +125°C |     | 27   | 35   |      |
| ENABLE INPUT                            | •  |   |     |      |      |      |
| V <sub>(EN_IH)</sub>                    | Enable input high threshold                              |   |     |      | 2    | V    |
| V <sub>(EN_IL)</sub>                    | Enable input low threshold                               |   | 0.5 | 0.85 | 1.2  | V    |
| V <sub>(EN_Hys)</sub>                   | Enable Hysteresis  |   |     | 485  |      | mV   |
| I <sub>(EN)</sub>                       | Enable sink current                                      | V <sub>(EN)</sub> = 12 V  |     | 55   | 155  | nA   |
| V <sub>ANODE</sub> to V <sub>CATH</sub> | HODE   |   |     |      |      |      |
| V <sub>(AC REG)</sub>                   | Regulated Forward V <sub>(AC)</sub> Threshold            |   | 7.5 | 12.8 | 18.7 |      |
| V <sub>(AC_FWD)</sub>                   | V <sub>(AC)</sub> threshold from RCB to oFCB             |   | 75  | 105  | 140  | mV   |
| V <sub>(AC_REV)</sub>                   | V <sub>(AC)</sub> threshold for reverse current blocking |   | -12 | -5.6 | -1.3 |      |
| GATE DRIVE                              |  |   |     |      | '    |      |
| V <sub>(GATE)</sub> - V <sub>(A)</sub>  |  | 3 V < V <sub>(C)</sub> < 65 V   | 9.5 |      | 13   | V    |
| I <sub>(GATE)</sub>                     | Regulation max sink current                              | $V_{(A)} - V_{(C)} = 0 \text{ V},$<br>$V_{(GATE)} - V_{(A)} = 5 \text{ V}$                                | 8.5 | 22   | 39   | μΑ   |
| (===)                                   | Peak Pull down current                                   | $V_{(A)} - V_{(C)} = -20 \text{ mV}$  |     | 2.5  |      | Α    |
| R <sub>GATE</sub>                       | GATE pull down resistance                                | $V_{(A)} - V_{(C)} = -20 \text{ mV},$<br>$V_{(GATE)} - V_{(A)} = 100 \text{ mV}$                          |     | 1.2  |      | Ω    |
| BOOST REGUL                             | ATOR CHARGE PUMP   |   |     |      |      |      |
| V V                                     | Boost output rising threshold                            |   |     | 13   | 15.5 | V    |
| $V_{(CAP)} - V_{(C)}$                   | Hysteresis   |   |     | 1.1  |      | V    |

## **6.5 Electrical Characteristics (continued)**

 $T_J$  = -40°C to +125°C; typical values at  $T_J$  = 25°C,  $V_{(A)}$  =  $V_{(C)}$  = 12 V,  $C_{(CAP)}$  = 1  $\mu$ F,  $V_{(EN)}$  = 2 V, over operating free-air temperature range (unless otherwise noted)

|                           | PARAMETER                                    | TEST CONDITIONS   | MIN  | TYP   | MAX   | UNIT |
|---------------------------|--|---|------|-------|-------|------|
| I <sub>(CAP)</sub>        | Boost load capacity                          | $V_{(CAP)} - V_{(C)} = 7.5 \text{ V}$                         |      | 29    |       |      |
|                           | Peak Inductor current limit                  | V <sub>(C)</sub> = 12 V                                       | 110  | 140   | 175   | mA   |
| $I_{(LX)}$                | Peak inductor current limit                  | V <sub>(C)</sub> = 3 V  |      |       | 210   |      |
| R <sub>(LX)</sub>         | Low side switch on-resistance                |   | 1.3  | 2.7   | 5.1   | Ω    |
|                           | SING (VSNS, SW) AND OVER VOLTAGE             | DETECTION (OVP, PD)   |      |       |       |      |
| R <sub>(SW)</sub>         | Battery sensing disconnect switch resistance |   | 104  | 226   | 430   | Ω    |
| V <sub>(OVR)</sub>        | Overvoltage threshold input, risIng          |   | 1.13 | 1.231 | 1.33  | V    |
| V <sub>(OVF)</sub>        | Overvoltage threshold input, falling         |   | 1.03 | 1.125 | 1.215 | V    |
| V <sub>(OV_Hys)</sub>     | OV Hysteresis                                |   |      | 110   |       | mV   |
| I <sub>(OV)</sub>         | OV Input leakage current                     | 0 V < V <sub>(OV)</sub> < 5 V                                 |      | 50    | 110   | nA   |
| I <sub>(PD_SRC)</sub>     | Pull up current                              | 3 V < V <sub>(C)</sub> < 65 V                                 | 43   | 50    | 60    | μA   |
| I <sub>(PD_SINK,Pk)</sub> | Peak Pull down current                       | $V_{(OV)} > V_{(OVR)}$  | 55   | 88    | 117   | mA   |
| I <sub>(PD_SINK,DC)</sub> | DC Pull down current                         |   | 7    | 10    | 14    | mA   |
| CATHODE                   |  |   |      |       |       |      |
|                           | C POR Rising                                 |   | 2.58 | 2.8   | 2.95  | V    |
| $V_{(C)}$                 | C POR Falling                                |   | 2.35 | 2.6   | 2.85  | ٧    |
| 1                         | C sink surrent                               | $V_{(A)} = 12 \text{ V}, V_{(A)} - V_{(C)} = -100 \text{ mV}$ |      | 8.5   | 15    |      |
| I <sub>(C)</sub>          | C sink current                               | V <sub>(A)</sub> = -14 V, V <sub>(C)</sub> = 14 V             |      | 12.8  | 18    | μA   |

## **6.6 Switching Characteristics**

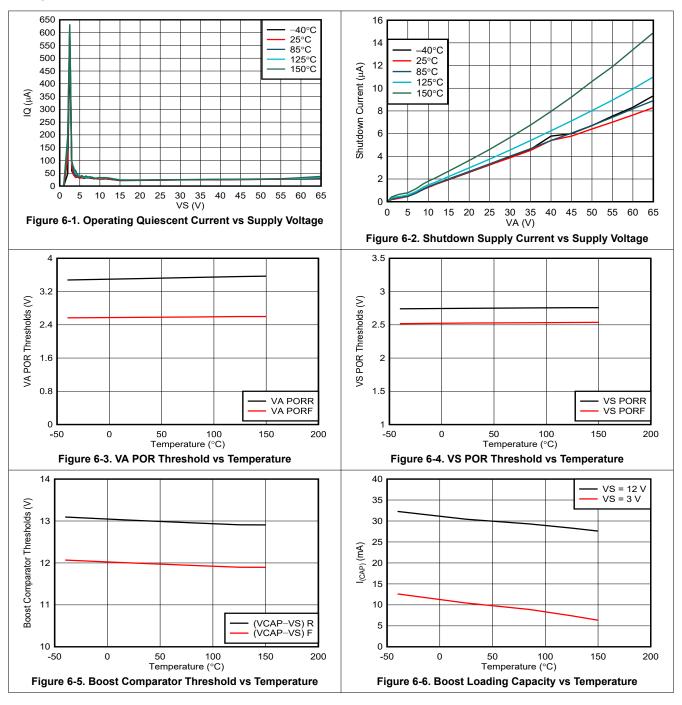
 $T_J = -40$ °C to +125°C; typical values at  $T_J = 25$ °C,  $V_{(A)} = V_{(C)} = 12$  V,  $C_{(CAP)} = 1$   $\mu$ F,  $V_{(EN)} = 2$  V, over operating free-air temperature range (unless otherwise noted)

|   | PARAMETER  | TEST CONDITIONS  | MIN | TYP  | MAX  | UNIT |
|---|--|--|-----|------|------|------|
| t <sub>A_POR(DLY)</sub>                 | A (low to high) to GATE turn-on delay            | $V_{(A)} \uparrow V(A \text{ POR}) \text{ to } V_{(GATE-A)} > 5 \text{ V},$<br>$C_{((GATE-A)} = 10 \text{ nF}$             |     |      | 200  | μs   |
| Forward voltage detection to GATE turn- |  | $V_{(A)} - V_{(C)} = -100 \text{ mV to } 700$<br>mV, $V_{(GATE - A)} > 5 \text{ V, } C_{((GATE - A))} = 10 \text{ nF}$     |     | 0.72 | 1.25 | μs   |
| <sup>t</sup> GATE_ON(DLY)               | on delay   | $V_{(A)} - V_{(C)} = -100 \text{ mV to } 700 \text{ mV, } V_{(GATE - A)} > 5 \text{ V, } C_{((GATE - A))} = 30 \text{ nF}$ |     | 1.02 | 1.9  | μs   |
| t <sub>GATE_OFF(DLY)</sub>              | Reverse voltage detection to GATE turn-off delay | $V_{(A)} - V_{(C)} = +30 \text{ mV to } -100 \text{ mV, } V_{(GATE - A)} < 1 \text{ V, } C_{((GATE - A))} = 10 \text{ nF}$ |     | 0.46 | 0.65 | μs   |
| t <sub>EN_OFF(DLY)PD</sub>              | EN to PD Delay                                   | EN ↓ to PD ↓   |     | 6.5  | 12   | μs   |
| t <sub>OV_OFF(DLY)PD</sub>              | OV to PD Deglitch                                | OV ↑ to PD ↓   |     | 0.9  | 1.5  | μs   |
| t <sub>PD_Pk</sub>                      | Peak Pull Down duration                          | $I_{(PD\_SINK,Pk)} \uparrow to I_{(PD\_SINK,DC)} \downarrow$   | 11  | 38   | 65   | μs   |

Product Folder Links: LM74722-Q1

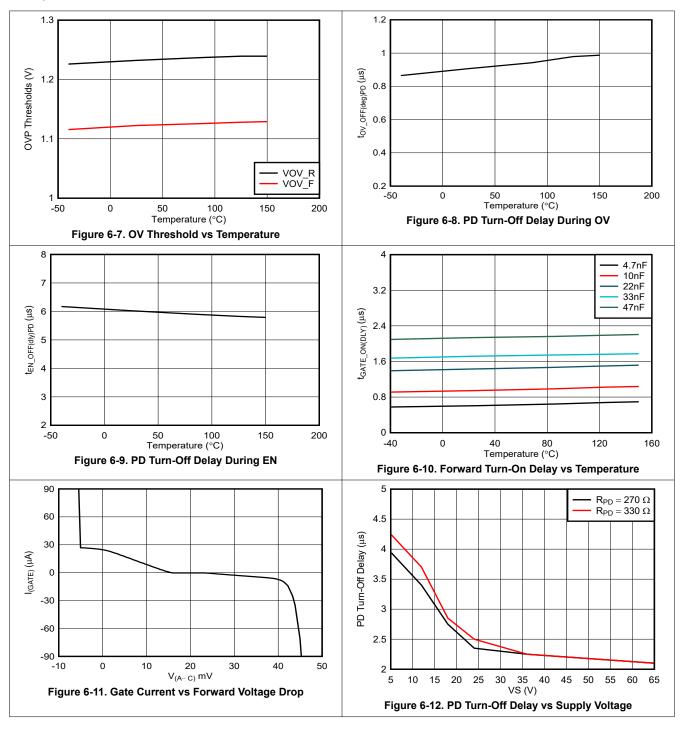


### 6.7 Typical Characteristics



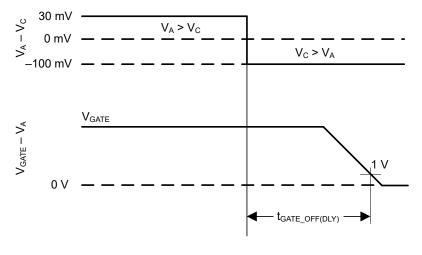


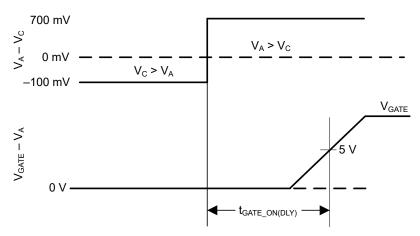
## **6.7 Typical Characteristics (continued)**





## 7 Parameter Measurement Information





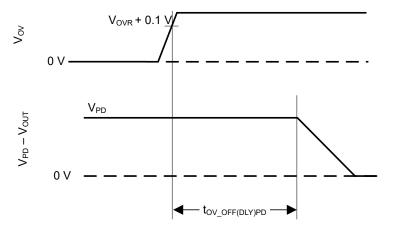


Figure 7-1. Timing Waveforms



## 8 Detailed Description

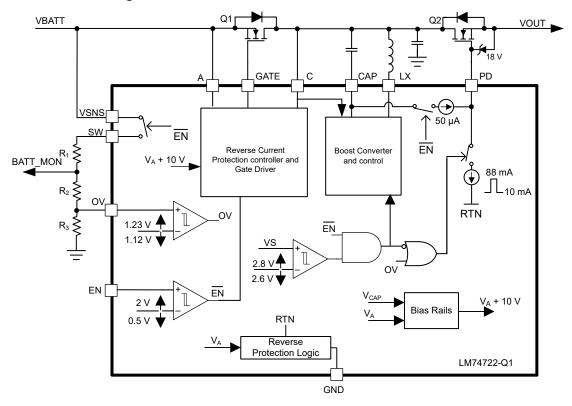
#### 8.1 Overview

The LM74722-Q1 ideal diode controller drives and controls external back-to-back N-Channel MOSFETs to emulate an ideal diode rectifier with power path ON and OFF control and overvoltage protection. The wide input supply of 3 V to 65 V allows protection and control of 12-V and 24-V automotive battery powered ECUs. IQ during operation (EN = High) is < 35  $\mu$ A and < 3.3  $\mu$ A during shutdown mode (EN = Low). The device can withstand and protect the loads from negative supply voltages down to –65 V. An integrated ideal diode controller (GATE) drives the first MOSFET to replace a Schottky diode for reverse input protection and output voltage holdup. A strong 30-mA boost regulator and short turn-ON and turn-OFF delay times of comparators ensures fast transient response ensuring robust and efficient MOSFET switching performance during automotive testing, such as ISO16750 or LV124, where an ECU is subjected to input short interruptions and AC superimpose input signals up to 200-kHz frequency. The device features an adjustable overvoltage cutoff protection feature for load dump protection.

The LM74722-Q1 controls the GATE of the MOSFET Q1 to regulate the forward voltage drop at 13 mV. The linear regulation scheme in these devices enables graceful control of the GATE voltage and turns off of the MOSFET during a reverse current event and ensures zero DC reverse current flow.

LM74722-Q1 PD gate drive can be used to drive load disconnect MOSFET (Q2). The back to back connected MOSFET configuration can be used when system requires overvoltage protection, inrush current protection or output load disconnect function.

### 8.2 Functional Block Diagram



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#### 8.3 Feature Description

#### 8.3.1 Dual Gate Control (GATE, PD)

The LM74722-Q1 features two separate gate control and driver outputs. That is, GATE and PD to drive back-to-back N-channel MOSFETs.

#### 8.3.1.1 Reverse Battery Protection (A, C, GATE)

A, C, GATE comprises of the ideal diode stage. Connect the source of the external MOSFET to A, drain to C and gate to GATE pin. The LM74722-Q1 has integrated reverse input protection down to –65 V.

In LM74722-Q1, the voltage drop across the MOSFET is continuously monitored between the A and C pins. The GATE to A voltage is adjusted as needed to regulate the forward voltage drop at 13 mV (typical). This closed loop regulation scheme enables graceful turn-off of the MOSFET during a reverse current event and ensures zero DC reverse current flow. This scheme ensures robust performance during slow input voltage ramp down tests. Along with the linear regulation amplifier scheme, the LM74722-Q1 also integrates a fast reverse voltage comparator. When the voltage drop across A and C reaches  $V_{(AC\_REV)}$  threshold, then the GATE goes low within 0.5  $\mu$ s (typical). This fast reverse voltage comparator scheme ensures robust performance during fast input voltage ramp down tests such as input micro-shorts. The external MOSFET is turned ON back when the voltage across A and C hits the  $V_{(AC\_FWD)}$  threshold within 0.72  $\mu$ s (typical). As shown in Figure 8-1, for ideal diode only designs, connect LM74722-Q1.

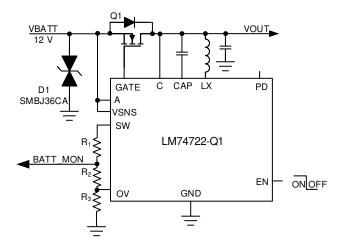


Figure 8-1. Configuring LM74722-Q1 for Ideal Diode Only

#### 8.3.1.2 Load Disconnect Switch Control (PD)

The PD pin provides a 50-µA drive and 88-mA peak pulldown strength for the load disconnect switch stage. Connect the Gate of the FET to PD pin. Place a 18-V Zener (Dz) across the FET gate and source.

For inrush current limiting, connect C<sub>dVdT</sub> capacitor and R<sub>1</sub> as shown in Figure 8-2.



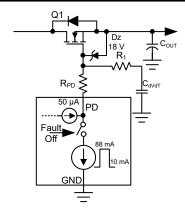


Figure 8-2. Inrush Current Limiting

The  $C_{dVdT}$  capacitor is required for slowing down the PD voltage ramp during power up for inrush current limiting. Use Equation 1 to calculate  $C_{dVdT}$  capacitance value.

$$C_{dVdT} = \frac{I_{PD\_DRV} \times C_{OUT}}{I_{INRUSH}}$$
(1)

where  $I_{PD\_DRV}$  is 50  $\mu$ A (typical),  $I_{INRUSH}$  is the inrush current, and  $C_{OUT}$  is the output load capacitance. An extra resistor,  $R_1$ , in series with the  $C_{dVdT}$  capacitor improves the turn-off time.

PD is pulled low during the following conditions:

- During an OV event with the OV pin voltage rising above the V<sub>(OVR)</sub> threshold
- When the EN pin is pulled low with V<sub>(EN)</sub> driven lower than V<sub>(EN IL)</sub> level
- When the voltage at VS pin drops below the V<sub>(VS POR)</sub> falling threshold

During these conditions, the FET Q1 turns OFF with its GATE connected to its SOURCE terminal through the external Zener (Dz).

Use Equation 2 to the peak power dissipated in the LM74722-Q1 at the instance of PD pulldown.

$$P_{PD\_peak} = V_{OUT} \times I_{PD\_SINK}$$
 (2)

where

I<sub>PDSINK</sub> peak is the peak sink current of 88 mA (typical)

In the system designs with input voltage above 48 V, TI recommends to place a resistor,  $R_{PD}$ , in series with the PD pin as shown in Figure 8-2. The peak power dissipation during the pulldown events gets distributed in  $R_{PD}$  and the internal PD switch. A resistor value in the range of 270  $\Omega$  to 330  $\Omega$  can be selected to limit the device power dissipation within the safe limits.

### 8.3.1.3 Overvoltage Protection and Battery Voltage Sensing (VSNS, SW, OV)

A disconnect switch is integrated between VSNS and SW pins. When the device is enabled, this internal switch allows input voltage monitoring by connecting a resistor divider from SW pin to GND. This switch is turned OFF when EN pin is pulled low. This action helps to reduce the leakage current through the resistor divider network during system shutdown state (IGN OFF state).

LM74722-Q1 has an OV pin which can be used to design overvoltage cutoff (OV setpoint referred to input side, VIN) or overvoltage clamp functionality (OV setpoint referred to output side, VOUT).

Figure 8-3 shows a typical resistor ladder connection for battery voltage sensing and overvoltage threshold programming.

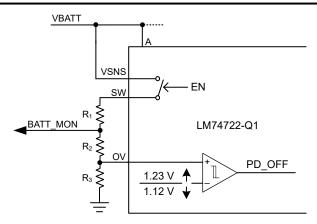


Figure 8-3. Programming Overvoltage Threshold and Battery Voltage Sensing

#### 8.3.2 Boost Regulator

The LM74722-Q1 integrates a boost converter to provide voltage necessary to drive the external N-channel MOSFETs for the ideal diode and the load disconnect stages. Place a 1- $\mu$ F capacitor across drain of the FET to GND and across the CAP pin to drain of the FET. Use a 100- $\mu$ H inductor with saturation current rating > 175 mA. For the boost converter to be enabled, the EN pin voltage must be above the specified input high threshold, V<sub>(ENR)</sub>. The boost converter has a maximum output load capacity of 30-mA typical. If EN pin is pulled low, then the boost converter remains disabled.

#### 8.4 Device Functional Modes

#### **Shutdown Mode**

The LM74722-Q1 enters shutdown mode when the EN pin voltage is below the specified input low threshold,  $V_{(EN\_IL)}$ . Both the gate drivers (GATE and PD) and the boost regulator are disabled in shutdown mode. During shutdown mode, the LM74722-Q1 enters low IQ operation with a total input quiescent consumption of 1.5  $\mu$ A (typical).



## 9 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

LM74722-Q1 controls two N-channel power MOSFETs with GATE used to control diode MOSFET to emulate an ideal diode and PD controlling second MOSFET for power path cutoff when disabled or during an overvoltage protection and provide inrush current limiting. IQ during operation (EN = High) is < 38  $\mu$ A and < 3.5  $\mu$ A during shutdown mode (EN = Low). LM74722-Q1 can be placed into low quiescent current mode using EN = low, where both GATE and PD are turned OFF.

## 9.2 Typical 12-V Reverse Battery Protection Application

Figure 9-1 shows a typical application circuit of LM74722-Q1 configured to provide reverse battery protection with overvoltage protection and inrush current limiting.

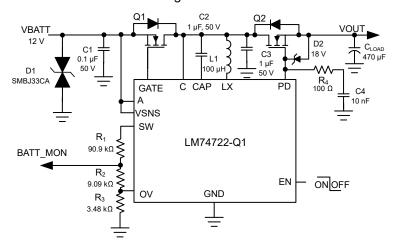


Figure 9-1. Typical Application Circuit – 12-V Reverse Battery Protection and Overvoltage Protection

## 9.2.1 Design Requirements for 12-V Battery Protection

Table 9-1 lists the system design requirements.

Table 9-1. Design Parameters - 12-V Reverse Battery Protection and Overvoltage Protection

| DESIGN PARAMETER                         | EXAMPLE VALUE  |  |  |
|--|--|--|--|
| Operating input voltage range            | 12-V battery, 12-V nominal with 3.2-V cold crank and 35-V load dump      |  |  |
| Output power                             | 50 W   |  |  |
| Output current range                     | 4-A nominal, 5-A maximum   |  |  |
| Input capacitance                        | 0.1-μF minimum   |  |  |
| Output capacitance                       | 0.1-μF minimum, (optional 220 μF for E-10 functional class A performance |  |  |
| Overvoltage cutoff                       | 37 V, output cutoff > 37 V   |  |  |
| AC super imposed test                    | 2-V peak-peak 100 kHz  |  |  |
| Automotive transient immunity compliance | ISO 7637-2, ISO 16750-2 and LV124  |  |  |
| Battery monitor ratio                    | 8:1  |  |  |

Product Folder Links: LM74722-Q1

### 9.2.1.1 Automotive Reverse Battery Protection

#### 9.2.1.1.1 Input Transient Protection: ISO 7637-2 Pulse 1

ISO 7637-2 pulse 1 specifies negative transient immunity of electronic modules connected in parallel with an inductive load when the battery is disconnected. A typical pulse 1 specified in ISO 7637-2 starts with battery disconnection where supply voltage collapses to 0 V followed by -150 V 2 ms applied with a source impedance of 10  $\Omega$  at a slew rate of 1  $\mu$ s on the supply input. LM74722-Q1 blocks reverse current and prevents the output voltage from swinging negative, protecting the rest of the electronic circuits from damage due to negative transient voltage. MOSFET Q1 is quickly turned off within 0.5  $\mu$ s by fast reverse comparator of LM74722-Q1. A single bidirectional TVS is required at the input to clamp the negative transient pulse within the operating maximum voltage across cathode to anode of 85 V and does not violate the MOSFET Q1 drain-source breakdown voltage rating.

Figure 9-2 shows ISO 7637-2 pulse 1 performance of LM74722-Q1.

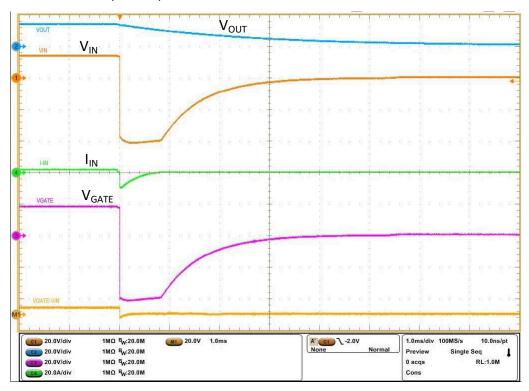
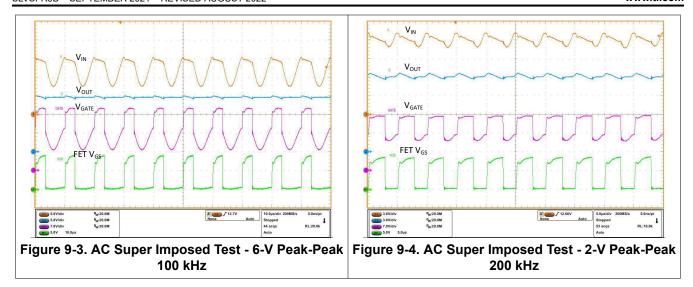


Figure 9-2. Performance During ISO 7637-2 Pulse 1 Test

#### 9.2.1.1.2 AC Super Imposed Input Rectification: ISO 16750-2 and LV124 E-06

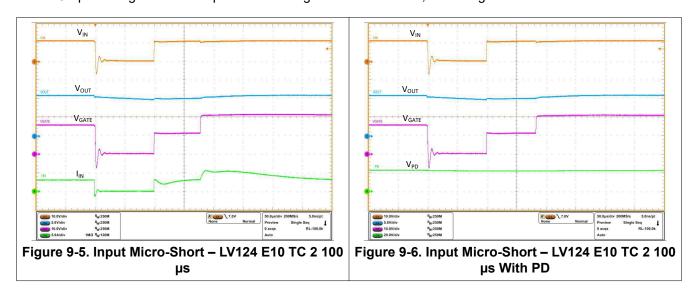
Alternators are used to power the automotive electrical system and charge the battery during normal run time of the vehicle. Rectified alternator output contains residual AC ripple voltage superimposed on the DC battery voltage due to various reasons. These reasons include engine speed variation, regulator duty cycle with field switching ON and OFF, and electrical load variations. On a 12-V battery supply, alternator output voltage is regulated by a voltage regulator between 14.5 V to 12.5 V by controlling the field current of alternator rotor. All electronic modules are tested for proper operation with superimposed AC ripple on the DC battery voltage. AC super imposed test specified in ISO 16750-2 and LV124 E-06 requires AC ripple of 2-V peak-peak on a 13.5-V DC battery voltage, swept from 15 Hz to 30 kHz. LM74722-Q1 rectifies the AC superimposed voltage by turning the MOSFET Q1 OFF quickly to cut off reverse current and turning the MOSFET Q1 ON quickly during forward conduction. Figure 9-3 shows active rectification of 6-V peak-peak 100-kHz AC input by LM74722-Q1. Fast turn-off and quick turn-on of the MOSFET reduces power dissipation in the MOSFET Q1, and active rectification reduces power dissipation in the output hold-up capacitor ESR by half. Figure 9-4 shows active rectification of 2-V peak-peak 200-kHz AC input.



#### 9.2.1.1.3 Input Micro-Short Protection: LV124 E-10

E-10 test specified in LV124 standard checks for immunity of electronic modules to short interruptions in power supply input due to contact issues or relay bounce. During this test (case 2), micro-short is applied on the input for a duration as low as 10 μs to several ms. For a functional pass status A, electronic modules are required to run uninterrupted during the E-10 test (case 2) with 100-μs duration. When input micro-short is applied for 100 μs, LM74722-Q1 quickly turns off MOSFET Q1 by shorting GATE to ANODE (source of MOSFET) within 0.5 μs to prevent the output from discharging and the PD remains ON keeping MOSFET Q2 ON, enabling fast recovery after the input short is removed.

Figure 9-5 shows performance of LM74722-Q1 during E10 input power supply interruption test case 2. After the input short is removed, input voltage recovers and MOSFET Q1 is turned back ON within 200 μs. Note that dual-gate drive topology allows MOSFET Q2 to remain ON during the test and helps in restoring the input power faster. Output voltage remains unperturbed during the entire duration, achieving functional status A.



#### 9.2.2 Detailed Design Procedure

#### 9.2.2.1 Design Considerations

Table 9-1 summarizes the design parameters that must be known for designing an automotive reverse battery protection circuit with overvoltage cutoff. During power up, inrush current through MOSFET Q2 must be limited so that the MOSFET operates well within its SOA. Maximum load current, maximum ambient temperature, and thermal properties of the PCB determine the R<sub>DSON</sub> of the MOSFET Q2, and maximum operating voltage determines the voltage rating of the MOSFET Q2. Selection of MOSFET Q2 is determined mainly by the maximum operating load current, maximum ambient temperature, maximum frequency of AC super imposed voltage ripple, and ISO 7637-2 pulse 1 requirements. Overvoltage threshold is decided based on the rating of downstream DC/DC converter or other components after the reverse battery protection circuit. A single bi-directional TVS or two back-to-back uni-directional TVS are required to clamp input transients to a safe operating level for the MOSFETs Q1, Q2, and LM74722-Q1.

#### 9.2.2.2 Boost Converter Components (C2, C3, L1)

Place a minimum of a 1- $\mu$ F capacitor across CAP pin to C pin (C2) and across C pin to GND (C3) of LM74722-Q1. Use a 100- $\mu$ H inductor (L1) with saturation current rating > 175 mA. Example: XPL2010-104ML from coil craft.

#### 9.2.2.3 Input and Output Capacitance

TI recommends a minimum input capacitance C1 of 0.1 µF and output capacitance C<sub>OUT</sub> of 0.1 µF.

### 9.2.2.4 Hold-Up Capacitance

Usually, bulk capacitors are placed on the output due to various reasons, such as uninterrupted operation during power interruption or micro-short at the input, holdup requirements for doing a memory dump before turning of the module, and filtering requirements as well. This design considers minimum bulk capacitors requirements for meeting functional status A during LV124 E10 test case 2 100-µs input interruption. To achieve functional pass status A, acceptable voltage drop in the output of LM74722-Q1 is based on the UVLO settings of downstream DC/DC converters. For this design, 2.5-V drop in output voltage for 100 µs is considered and the minimum holdup capacitance required is calculated by

$$C_{\text{(HOLD\_UP\_MIN)}} = \frac{I_{\text{LOAD\_MAX}} \times 100 \ \mu\text{s}}{\Delta V_{\text{OUT}}}$$
(3)

Minimum holdup capacitance required for 1-V drop in 100 μs is 470 μF.

#### 9.2.2.5 Overvoltage Protection and Battery Monitor

Resistors  $R_1$ ,  $R_2$  and  $R_3$  connected in series are used to program the overvoltage threshold and battery monitor ratio. The resistor values required for setting the overvoltage threshold,  $V_{OV}$ , to 37 V and battery monitor ratio  $V_{BATT\ MON}$ : $V_{BATT\ to\ 1:8}$  are calculated by solving Equation 4 and Equation 5.

$$V_{OVR} = \frac{R_3 \times V_{OV}}{R_1 + R_2 + R_3} \tag{4}$$

$$V_{BAT\_MON} = \frac{(R_2 + R_3) \times V_{OV}}{R_1 + R_2 + R_3}$$
 (5)

For minimizing the input current drawn from the battery through resistors  $R_1$ ,  $R_2$  and  $R_3$ , TI recommends to use higher value of resistance. Using high value resistors adds error in the calculations because the current through the resistors at higher value becomes comparable to the leakage current into the OV pin. Maximum leakage current into the OV pin is 1  $\mu$ A and choosing ( $R_1 + R_2 + R_3$ ) < 120  $k\Omega$  ensures current through resistors is 100 times greater than leakage through OV pin.

Based on the device electrical characteristics,  $V_{OVR}$  is 1.23 V and battery monitor ratio ( $V_{BATT\_MON}$  /  $V_{BATT}$ ) is designed for a ratio of 1:8. To limit ( $R_1 + R_2 + R_3$ ) < 120 k $\Omega$ , select ( $R_1 + R_2$ ) = 100 k $\Omega$ . Solving Equation 4 gives  $R_3$  = 3.45 k $\Omega$ . Solving Equation 5 for R2 using ( $R_1 + R_2$ ) = 100 k $\Omega$  and  $R_3$  = 3.45 k $\Omega$ , gives  $R_2$  = 9.48 k $\Omega$  and  $R_1$  = 90.52 k $\Omega$ .

Standard 1% resistor values closest to the calculated resistor values are R1 = 90.9 k $\Omega$ , R2 = 9.09 k $\Omega$ , and R3 = 3.48 k $\Omega$ .

#### 9.2.2.6 MOSFET Selection: Blocking MOSFET Q1

For selecting the blocking MOSFET Q1, important electrical parameters are the maximum continuous drain current  $I_D$ , the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the maximum drain-to-source voltage  $V_{GS(MAX)}$ , and the maximum source current through body diode and the drain-to-source ON resistance  $R_{DSON}$ .

The maximum continuous drain current, ID, rating must exceed the maximum continuous load current.

The maximum drain-to-source voltage,  $V_{DS(MAX)}$ , must be high enough to withstand the highest differential voltage seen in the application. This includes all the automotive transient events and any anticipated fault conditions. TI recommends to use MOSFETs with  $V_{DS}$  voltage rating of 60 V along with a single bidirectional TVS or a  $V_{DS}$  rating 40-V maximum rating along with two unidirectional TVS connected back-to-back at the input.

The maximum  $V_{GS}$  LM74722-Q1 can drive is 14 V, so a MOSFET with 15-V minimum  $V_{GS}$  rating must be selected. If a MOSFET with < 15-V  $V_{GS}$  rating is selected, a Zener diode can be used to clamp  $V_{GS}$  to safe level, but this results in increased  $I_Q$  current.

To reduce the MOSFET conduction losses, lowest possible  $R_{DS(ON)}$  is preferred, but selecting a MOSFET based on low  $R_{DS(ON)}$  cannot always be beneficial. Higher  $R_{DS(ON)}$  provides increased voltage information to the LM74722-Q1 reverse comparator at a lower reverse current. Reverse current detection is better with increased  $R_{DS(ON)}$ . Choosing a MOSFET with < 50-mV forward voltage drop at maximum current is a good starting point. Based on the design requirements, BUK7Y4R8-60E MOSFET is selected

### 9.2.2.7 MOSFET Selection: Load Disconnect MOSFET Q2

The  $V_{DS}$  rating of the MOSFET Q2 must be sufficient to handle the maximum system voltage along with the input transient voltage. For this 12-V design, transient overvoltage events are during suppressed load dump 35 V 400 ms and ISO 7637-2 pulse 2 A 50 V for 50  $\mu$ s. Further, ISO 7637-2 pulse 3B is a very fast repetitive pulse of 100 V 100 ns that is usually absorbed by the input and output ceramic capacitors. The maximum voltage on the 12-V battery can be limited to < 40 V the minimum recommended input capacitance of 0.1  $\mu$ F. The 50-V SO 7637-2 pulse 2 A can also be absorbed by input and output capacitors and its amplitude can be reduced to 40-V peak by placing sufficient amount of capacitance at input and output. Choose a MOSFET with  $\geq$  40-V  $V_{DS}$  rating .

The VGS rating of the MOSFET Q2 must be higher than that maximum boost drive output of 15.5 V. FET with VGS absolute maximum rating of +/- 20 VGS is selected.

Inrush current through the MOSFET during input hot-plug into the 12-V battery is determined by output capacitance. External capacitor on HGATE,  $C_{DVDT}$ , is used to limit the inrush current during input hot-plug or start-up. The value of inrush current determined by Equation 1 must be selected to ensure that the MOSFET Q2 is operating well within its safe operating area (SOA). To limit inrush current to 250 mA, value of  $C_{DVDT}$  is 10.43 nF. The closest standard value of 10.0 nF is chosen.

Duration of inrush current is calculated by Equation 6

$$T_{INRUSH} = \frac{12 \times C_{OUT}}{I_{INRUSH}}$$
 (6)

Calculated inrush current duration is 2.36 ms with 250-mA inrush current.

MOSFET BUK7Y4R8-60E having 60-V  $V_{DS}$  and  $\pm 20$ -V  $V_{GS}$  rating is selected for Q2. Power dissipation during inrush is well within the MOSFET safe operating area (SOA).

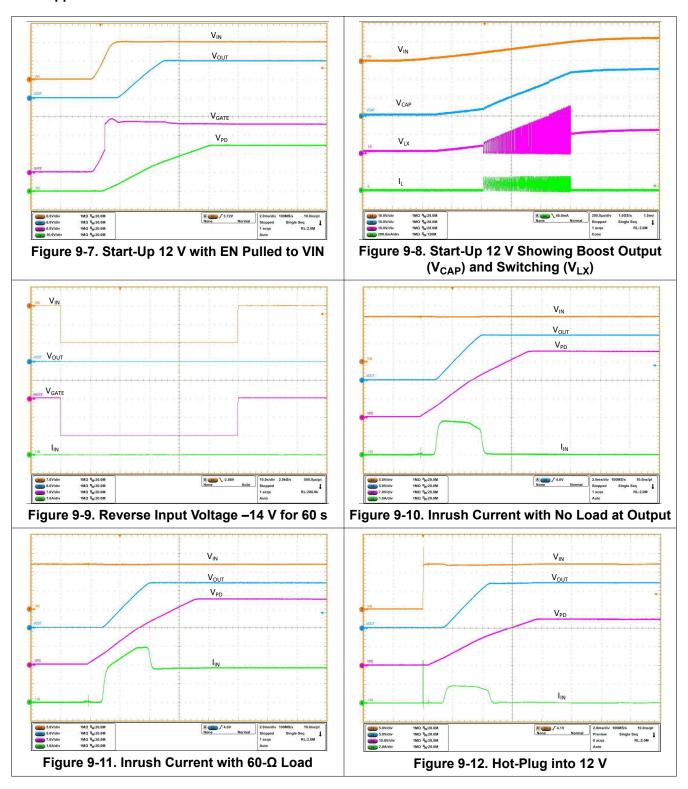


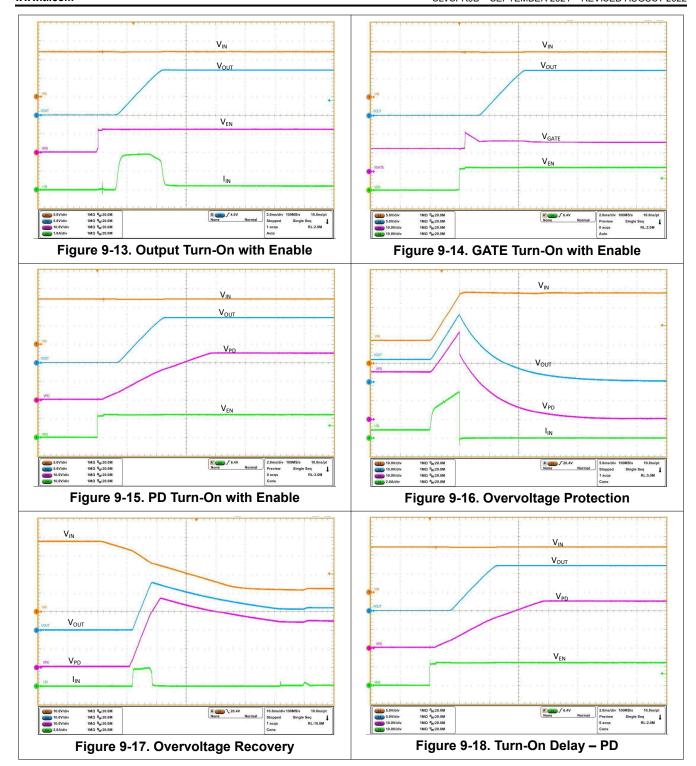
### 9.2.2.8 TVS Selection

TI recommends a 600-W SMBJ TVS such as SMBJ33CA for input transient clamping and protection. For detailed explanation on TVS selection for 12-V battery systems, refer to TVS Selection for 12-V Battery Systems.

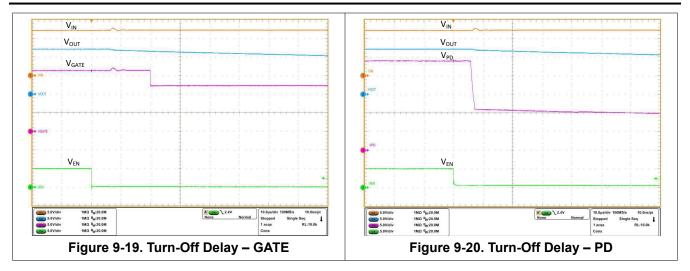


### 9.2.3 Application Curves









## 9.3 What to Do and What Not to Do

Leave the exposed pad (RTN) of the IC floating. Do not connect the exposed pad (RTN) to the GND plane. Connecting the RTN to the GND disables the reverse polarity protection feature.

## 10 Power Supply Recommendations

## **10.1 Transient Protection**

When the external MOSFETs turn OFF during the conditions such as overvoltage cutoff, reverse current blocking, and EN causing an interruption of the current flow, the input line inductance generates a positive voltage spike on the input and output inductance generates a negative voltage spike on the output. The peak amplitude of voltage spikes (transients) depends on the value of inductance in series to the input or output of the device. These transients can exceed the *Absolute Maximum Ratings* of the device if steps are not taken to address the issue.

Typical methods for addressing transients include:

- · Minimizing lead length and inductance into and out of the device
- · Using large PCB GND plane
- Use of a Schottky diode across the output and GND to absorb negative spikes
- A low value ceramic capacitor (C<sub>(IN)</sub> to approximately 0.1 μF) to absorb the energy and dampen the transients

Equation 8 can estimate the approximate value of input capacitance.

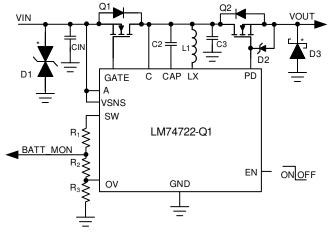
$$V_{\text{spike}(\text{Absolute})} = V_{\text{(IN)}} + I_{\text{(Load)}} \times \sqrt{\frac{L_{\text{(IN)}}}{C_{\text{(IN)}}}}$$
(7)

#### where

- V<sub>(IN)</sub> is the nominal supply voltage
- I<sub>(LOAD)</sub> is the load current
- L<sub>(IN)</sub> equals the effective inductance seen looking into the source
- C<sub>(IN)</sub> is the capacitance present at the input

Some applications can require additional Transient Voltage Suppressor (TVS) to prevent transients from exceeding the *Absolute Maximum Ratings* of the device. These transients can occur during EMC testing, such as automotive ISO7637 pulses.

Figure 10-1 shows the circuit implementation with optional protection components (a ceramic capacitor, TVS, and Schottky diode).



<sup>\*</sup> Optional components needed for suppression of transients.

Figure 10-1. Circuit Implementation With Optional Protection Components for LM74722-Q1

### 10.2 TVS Selection for 12-V Battery Systems

In selecting the TVS, important specifications are breakdown voltage and clamping voltage. The breakdown voltage of the TVS+ must be higher than 24-V jump start voltage and 35-V suppressed load dump voltage and less than the maximum ratings of LM74722-Q1 (65 V). The breakdown voltage of TVS- must be beyond the maximum reverse battery voltage -16 V, so that the TVS- is not damaged due to long time exposure to reverse connected battery.

Clamping voltage is the voltage the TVS diode clamps in high current pulse situations and this voltage is much higher than the breakdown voltage. In the case of an ISO 7637-2 pulse 1, the input voltage goes up to -150 V with a generator impedance of 10  $\Omega$ . This translates to 15 A flowing through the TVS- and the voltage across the TVS is close to its clamping voltage.

The next criterion is that the absolute maximum rating of cathode to anode voltage of the LM74722-Q1 (85 V) and the maximum V<sub>DS</sub> rating MOSFET are not exceeded. In the design example, 60-V rated MOSFET is chosen and maximum limit on the cathode to anode voltage is 60 V.

During ISO 7637-2 pulse 1, the anode of LM74722-Q1 is pulled down by the ISO pulse, clamped by TVS-, and the MOSFET Q1 is turned off quickly to prevent reverse current from discharging the bulk output capacitors. When the MOSFET turns off, the cathode to anode voltage seen is equal to (TVS clamping voltage + output capacitor voltage). If the maximum voltage on output capacitor is 16 V (maximum battery voltage), then the clamping voltage of the TVS- must not exceed (60 V - 16) V = -44 V.

The SMBJ33CA TVS diode can be used for 12-V battery protection application. The breakdown voltage of 36.7 V meets the jump start, load dump requirements on the positive side and 16-V reverse battery connection on the negative side. During ISO 7637-2 pulse 1 test, the SMBJ33CA clamps at -44 V with 12 A of peak surge current and it meets the clamping voltage ≤ 44 V.

SMBJ series of TVS are rated up to 600-W peak pulse power levels and are sufficient for ISO 7637-2 pulses.

If 40-V rated MOSFET is choosen then maximum voltage across C (Drain of the MOSFET) and A (Source of the MOSFET) must not exceed 40-V. For 40-V MOSFET selection, two back-to-back connected uni-directional TVS diodes are required to protect against input transient events. On the positive side, the SMBJ33A TVS diode can be used for 12-V battery protection application. However on the negative side, TVS has to withstand 16-V reverse battery connection and clamping voltage has to be -(40 V - 16 V) = -24 V. SMBJ16A can be used.

### 10.3 TVS Selection for 24-V Battery Systems

For 24-V battery protection application, the TVS and MOSFET in Figure 9-1 must be changed to suit 24-V battery requirements.

The breakdown voltage of the TVS+ must be higher than 48-V jump start voltage, less than the absolute maximum ratings of anode and enable pin of LM74722-Q1 (70 V), and must withstand 65-V suppressed load dump. The breakdown voltage of TVS- must be lower than maximum reverse battery voltage -32 V, so that the TVS- does not damage due to long time exposure to reverse connected battery.

During ISO 7637-2 pulse 1, the input voltage goes up to -600 V with a generator impedance of 50  $\Omega$ . This translates to 12 A flowing through the TVS-. The clamping voltage of the TVS- cannot be the same as that of 12-V battery protection circuit. Because during the ISO 7637-2 pulse, the anode to cathode voltage seen is equal to (- TVS Clamping voltage + Output capacitor voltage). For 24-V battery application, the maximum battery voltage is 32 V, then the clamping voltage of the TVS- must not exceed, 85 V - 32 V = 53 V.

Single bi-directional TVS cannot be used for 24-V battery protection because breakdown voltage for TVS+ ≥ 65 V, maximum clamping voltage is ≤ 53 V and the clamping voltage cannot be less than the breakdown voltage. Two un-directional TVS connected back-to-back must be used at the input. For positive side TVS+, TI recommends SMBJ58A with the breakdown voltage of 64.4 V (minimum), 67.8 (typical). For the negative side TVS-, TI recommends SMBJ28A with breakdown voltage close to 32 V (to withstand maximum reverse battery voltage -32 V) and maximum clamping voltage of 42.1 V.

For 24-V battery protection, TI recommends that a 75-V rated MOSFET be used along with SMBJ28A and SMBJ58A connected back-to-back at the input.

Product Folder Links: LM74722-Q1

## 11 Layout

## 11.1 Layout Guidelines

- Connect A, GATE, and C pins of LM74722-Q1 close to the MOSFET SOURCE, GATE and DRAIN pins for the ideal diode stage.
- Use thick and short traces for source and drain of the MOSFET to minimize resistive losses because the high current path of for this solution is through the MOSFET.
- Connect the GATE pin of the LM74722-Q1 to the MOSFET GATE with short trace.
- Minimize the loops formed by capacitor across CAP pin and DRAIN of the FET and C3 to GND by placing
  these capacitors as close as possible. Keep the GND side of the C3 capacitor close to GND pin of LM74722Q1. Boost converter switching currents flow into LX, CAP, GND pins and C3 (across DRAIN of the FET to
  GND).
- Place transient suppression components, like input TVS and output Schottky, close to LM74722-Q1.

### 11.2 Layout Example

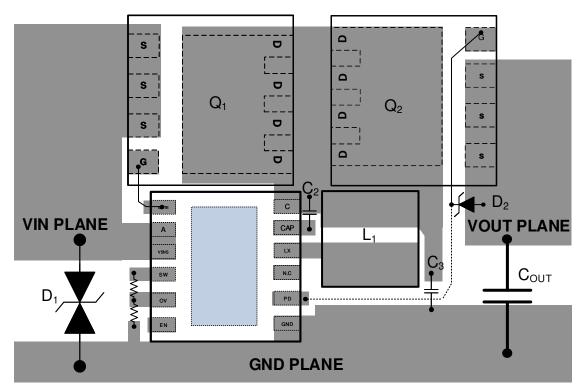


Figure 11-1. LM74722-Q1 Layout Example



## 12 Device and Documentation Support

## 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.3 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

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### 12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

| Orderable part number | Status (1) | Material type | Package   Pins  | Package qty   Carrier | RoHS (3) | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking (6) |
|-----------------------|------------|---------------|-----------------|-----------------------|----------|-------------------------------|----------------------------|--------------|------------------|
| LM74722QDRRRQ1        | Active     | Production    | WSON (DRR)   12 | 3000   LARGE T&R      | Yes      | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | L74722           |
| LM74722QDRRRQ1.A      | Active     | Production    | WSON (DRR)   12 | 3000   LARGE T&R      | Yes      | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | L74722           |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

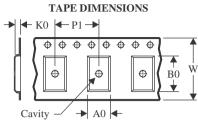
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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### TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

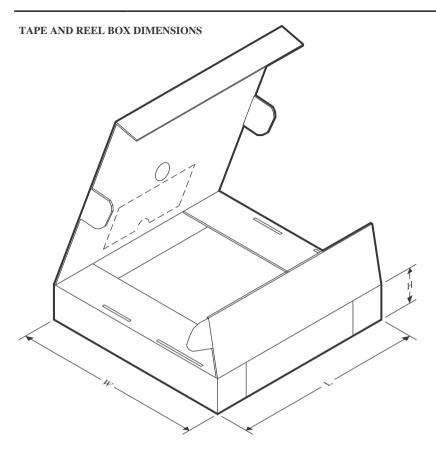


#### \*All dimensions are nominal

| Device         | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| LM74722QDRRRQ1 | WSON            | DRR                | 12 | 3000 | 330.0                    | 12.4                     | 3.3        | 3.3        | 1.1        | 8.0        | 12.0      | Q2               |

# **PACKAGE MATERIALS INFORMATION**

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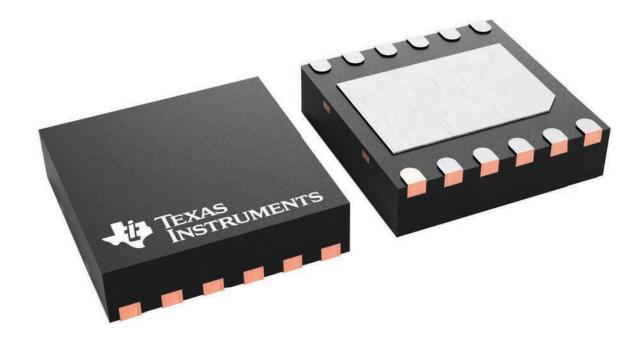
### \*All dimensions are nominal

| Ì | Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |  |
|---|----------------|--------------|-----------------|------|------|-------------|------------|-------------|--|
| ı | LM74722QDRRRQ1 | WSON         | DRR             | 12   | 3000 | 367.0       | 367.0      | 35.0        |  |

3 x 3, 0.5 mm pitch

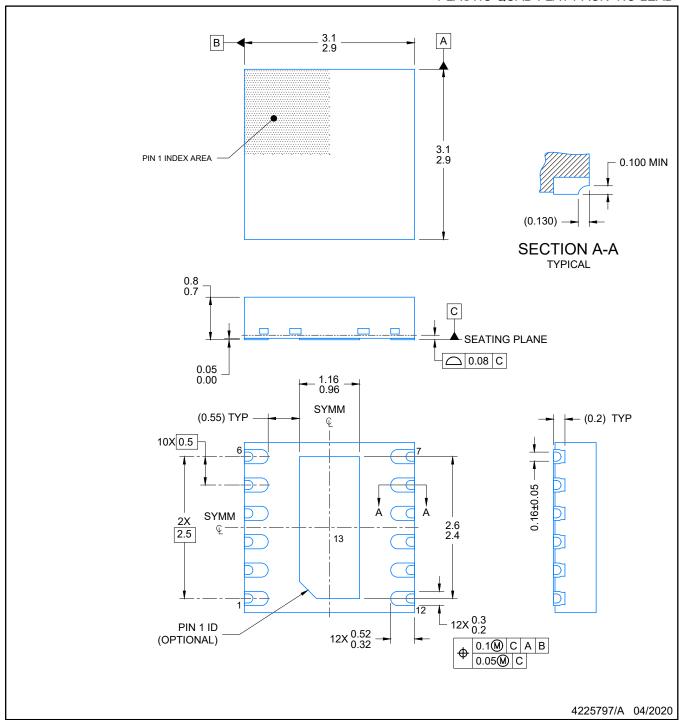
PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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PLASTIC QUAD FLAT PACK- NO LEAD

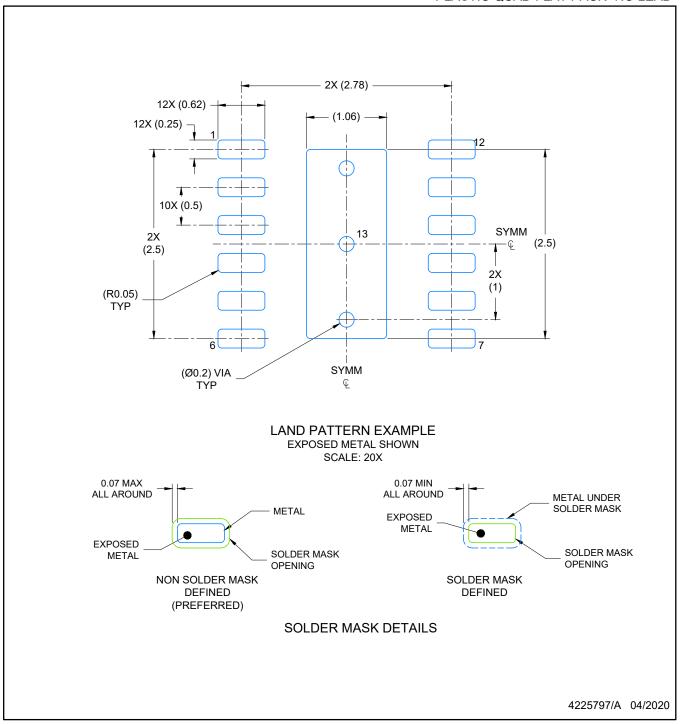


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC QUAD FLAT PACK- NO LEAD

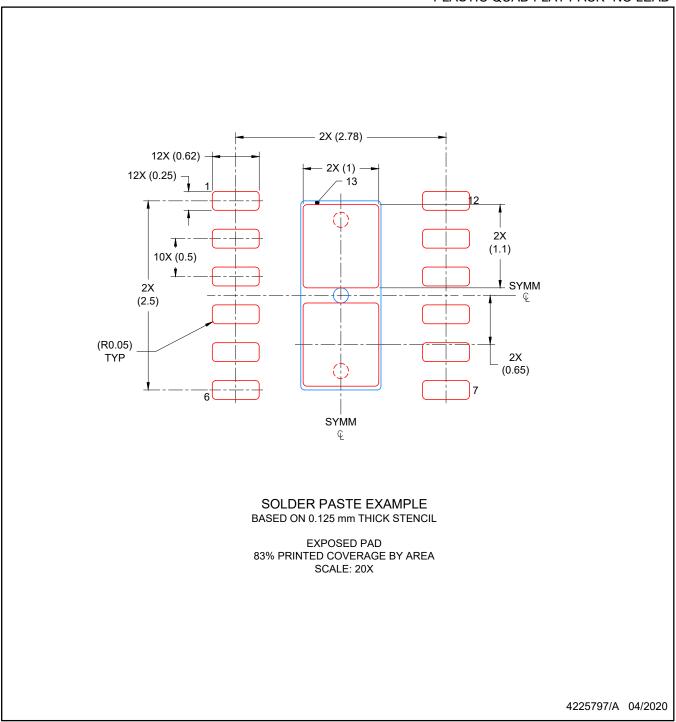


#### NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLAT PACK- NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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